

Notice of References Cited	Application/Control No. 09/242,191	Applicant(s)/Patent Under Reexamination RIERA, MICHEL	
	Examiner Thao T. Tran	Art Unit 1711	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Vander Heyden et al. Name	Classification
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	C	US-			
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NON-PATENT DOCUMENTS

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